

# Electronic Filing System (EFS) Data

## Electronic Patent Application Submission

### USPTO Use Only

EFS ID: 15333  
Application ID: 10063869  
Title of Invention: INSPECTION METHOD AND  
INSPECTION APPARATUS FOR  
SEMICONDUCTOR CIRCUIT  
First Named Inventor: Chihiro Araki  
Domestic/Foreign Application: Domestic Application  
Filing Date: null  
Effective Receipt Date: 2002-05-21   
Submission Type: Utility Patent Filing  
Filing Type: new-utility  
Confirmation Number: 0  
Attorney Docket Number: SIMTEK6349  
Digital Certificate Holder: cn=Ernest A. Beutler, ou=Registered Attorneys, ou=Patent and  
Trademark Office, ou=Department of Commerce, o=U.S.  
Government, c=US  
Certificate Message Digest: zToMcv96EnQfFnvpnvXDLg==  
Total Fees Authorized: \$780.0

Payment Category: CC - Credit Card  
Credit Card Number: \*\*\*\*2005  
Expiration Date: 12312002  
Card Holder Name: Ernest A Beutler Attorne  
RAM User ID: EFSPROD  
RAM Accounting Date: 2002-05-21  
RAM Sequence Number: 455743  
RAM Payment Status: RAM success  
Postal Code: 92660

# APPLICATION DATA SHEET

Electronic Version 0.0.11

Stylesheet Version: 1.0

Attorney Docket Number: SIMTEK6349

Publication Filing Type: new-utility

Application Type: utility

Title of Invention: INSPECTION METHOD AND INSPECTION APPARATUS FOR SEMICONDUCTOR CIRCUIT

Customer Number Attorney: 025776



Customer Number Correspondence Address: 025776



Foreign Priority:

2001-161739

JP 2001-05-30

Priority Claimed

## INVENTOR(s):

Primary Citizenship: JAPAN

Given Name: Chihiro

Family Name: Araki

Residence City: Shuuchi-gun

Residence Country: JP

Address: c/o 1450-6 Mori

Shuuchi-gun , JP